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INFORMATION DISCLOSURE CITATION PTO-1449			ATTY. DOCKET NO.		SERIAL NO.								
			20464-719	10/0	10/041,720								
			APPLICANT Dlugokecki et al.										
			FILING DATE 01/07/02	GROUP-Unknow		n 2827							
U.S. PATENT DOCUMENTS													
EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING	DATE						
AC	H1379	12/6/94	Meuer	451	38		·						
AC	3,627,901	12/14/71	Нарр	174	52								
AC	3,762,039	10/2/73	Douglass et al.	29	588								
AC	3,842,419	12/9/69	Rogers et al.	65	36								
AC	3,969,813	7/20/76	Minetti et al.	29	575								
AC	4,089,704	5/16/78	Heiss, Jr. et al.	134	29								
AC	4,359,360	11/16/82	Harris et al.	156	345								
AC	4,384,917	5/24/83	Wensink	156	627								
AC	4,474,621	10/2/84	Saccocio et al.	134	1								
AC	4,567,006	1/28/86	Covington et al.	264	22								
A C.	5,138,430	8/11/92	Gow, 3rd et al.	357	70		· · · · ·						
AC	5,149,662	9/22/92	Eichelberger	437	8								
AC	5,318,926	6/7/94	Dlugokecki	437	210								
AC	5,510,273	4/23/96	Quinn	437	3								
AC	5,589,402	12/31/96	Ramsey et al.	437	2								
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AC	5,700,697	12/23/97	Dlugokecki	437	8								
AC	5,747,385	5/5/98	Torii	438	690								
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EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS		LATION						
INTIALS						YES	NO						
4	WO 92/20096	11/12/96	PCT	HOIL	23/02								
AC	2-260548	10/23/90	Japan	HOIL	21/56								
AC	2-278740	11/15/90	Japan	HOIL	21/56	0							
AC	6-124405	5/6/94	Japan	GIIB	5/09		旦						
AC,	6-172196	6/21/94	Japan	ASHK	35/78								
EXAMINER X	nambles		DATE CONSIDERED 2124103										

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INFORMATION DISCLOSURE CITATION			20464-719 10/041,720									
	PTO-1449		APPLICANT Dlugokecki et al.									
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EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING	DATE					
AC	5,897,334	4/27/99	Ha et al.	438	107							
AC	5,919,729	7/6/99	Mori et al.	503	200							
AC	5,930,604	7/24/99	Leonard et al.	438	127							
AC	5,951,813	9/14/99	Warren	156	305							
AC	5,956,574	9/21/99	Ichikawa et al.	438	106							
AL	5,960,258	9/28/99	Moden	438	106							
AC	5,972,738	10/26/99	Vongfuangfoo et al.	438	124		<u> </u>					
AC	6,037,661	3/14/00	Palagonia et al.	257	723							
A (6,090,644	7/18/00	Moden	438	127							
AC	6,114,627	9/5/00	Moden	174	52.4							
AC	6,117,710	9/12/00	Mostafazadeh et al.	438	123							
AC	6,165,813	12/26/00	Quinn et al.	438	67							
AC	6,168,975	1/2/01	Zhang et al.	438	111							
AC	6,297,546	10/2/01	Moden	257	669							
AC	6,310,288	10/30/01	Moden	174	52.4							
AC	6,329,212	12/11/01	Dobrovolski	438	15							
AC	6,335,208	1/1/02	Lowry	438	4							
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40	60-124834	7/3/85	Japan	HOTT	21/66							
AC	61-110437	5/28/86	Japan	HOIL	24456							
14C	63-184347	7/29/88	Japan	HOIL	21/56	2						
AC	62-247553	10/28/87	Japan	HOIL	23/48							
AC	63-287043	11/24/88	Japan	HOIL	23/28		0					
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)												
EXAMINER 8/24/03 A Chamillas DATE CONSIDERED 8/24/03												

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